#### Before & After Reflow Characterization of FCBGA Voiding Utilizing High Resolution CT Scan, X-ray (2D & 3D) Imaging, and Cross Section with Digital Imaging

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#### ABSTRACT

A joint project between Flextronics Inc. and North Star Imaging Inc. is being conducted to correlate current x-ray imaging and cross-section analysis of BGA voiding with state of the art high resolution CT-Scan imaging. Our primary objective is to validate the void measurements obtained from non-destructive imaging techniques, with the physically measured void measurements of cross sectioning. A secondary goal is to characterize void properties before and after reflow.

Typical AXI inspection equipment provides one to three horizontal planes of reference for BGA void measurements. CT Scan imaging provides a full 3D volumetric representation of the BGA void, allowing for size, volume, and void position data. Information that can be used in failure analysis and process characterization projects, without physical destruction of the printed circuit board.

Five 50.0 mm FCBGA devices and five 52.5mm FCBGA devices, with known voiding, are being used in the study. The voiding for each device has been measured on a 3D AXI machine (Figure 1), a2D off-axis high resolution x-ray machine (Figure 2), and CT-Scan system (Figure 3). The devices will then be placed and reflowed onto printed circuit boards. After reflow, all the voiding will be measured again using each piece of equipment. In addition, select voids will be cross-sectioned, polished, and measured using a high magnification digital microscope and correlated to the other x-ray imaging tools.

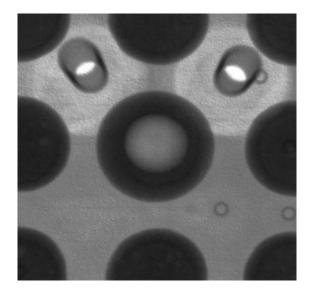


Figure 1 - Transmissive 2D X-ray Image of BGA Void

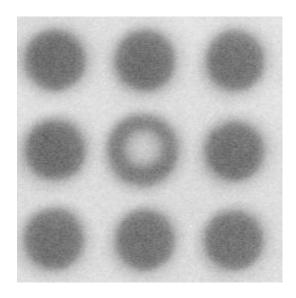


Figure 2 - 3D AXI Mid-Ball Image of BGA Void

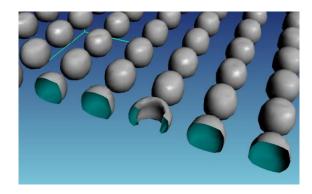


Figure 3 - CT Scan surface model, with partial cross section, of BGA void

#### INTRODUCTION

As complex electronic assemblies become faster and faster, power with associated heat dissipation, signal integrity (SI) and reliability become more important than ever. Solder joint voiding can potentially impact all of these. With cost pressures on companies producing these types of products, it is more important than ever to be able to properly diagnose and characterize voiding in a non-destructive fashion. Proper characterization will allow for adequate troubleshooting and process development needed to minimize or eliminate voiding. In addition, non-destructive void analysis can be used in failure analysis cases.

Over time, X-Ray technology used in the electronics industry has advanced from 2D transmissive, to 2D Off Axis, to 3D laminography, to 3D tomosynthesis. Resolution of x-ray tools has continued to advance along with the software required for automated analysis. Use of these tools has allowed identification and measurements of the voids in solder joints. Software has allowed for automated inspection of the solder joints to quickly identify and measure up 100 % of the solder joints per component and per assembly in a timely manner. Typically, this software allows for measurement at a specific point in the solder joint (i.e. PCB level, mid joint and Package level).

While many improvements have been made in these tools (including resolution), smaller voids and true position of these voids has been difficult to see without actual cross sectioning. Now with the latest advancements in X-Ray technology, a full high resolution 3D image is available using Cat Scan technology. CT technology allows for infinite cross sectioning in a non-destructive fashion.

The first objective of this work will be to correlate the most common X-Ray technologies used by the electronics industry. Each technology will be correlated, not only to the newest CT Scan technology but also to actual cross sections on a variety of void examples.

The second objective of this work will be to identify and characterize a variety of voids from incoming components through the SMT reflow process. Incoming components identified with solder voids will be subjected to a variety of reflow profile styles to determine what happens to them relative to size and position. Images and measurements will be taken before and after reflow using all the traditional X-Ray tools along with CT Scan. After all imaging has been completed; actual cross sections will be taken for comparison. In addition, components with incoming voids will be subjected to reflow under vacuum in an attempt to remove the voids prior to assembly.

#### METHODOLOGY

Design and fabricate custom fixtures capable of holding 50 x 50 mm FCBGA and a 52.5 x 52.5 mm FCBGA's in a dead bug position was needed for automated 3D inspection. Figure 4 shows the 10 up fixture while Figure 5 shows a close up view.



Figure 4 – Fixture for automated 3D X-Ray inspection

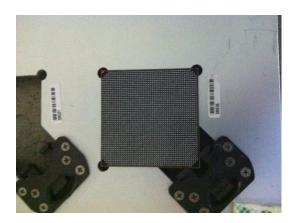


Figure 5 - Close up view of Fixture for automated 3D X-Ray inspection

Assemble one SMT Reflow Profile Board utilizing a large complex PCB with 50 x 50 mm and 52.5 x 52.5 mm FCBGA's.

Create three different style profiles called Ramp to Peak (Figure 6), Long Soak (Figure 7) and Medium Soak (Figure 8)

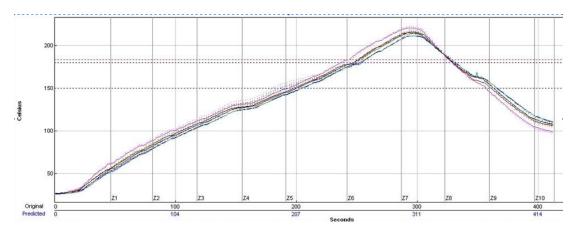


Figure 6 – Ramp to Peak SMT Reflow Profile

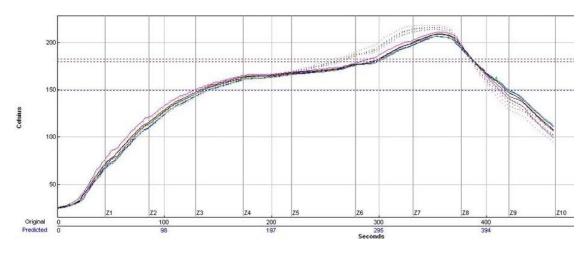


Figure 7 – Long Soak SMT Reflow Profile

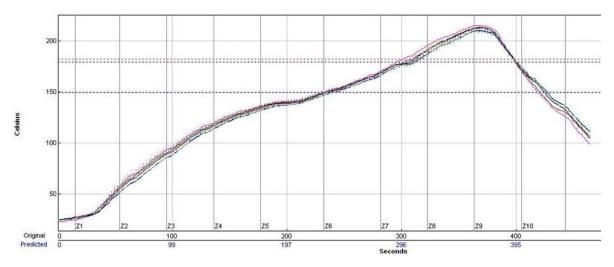
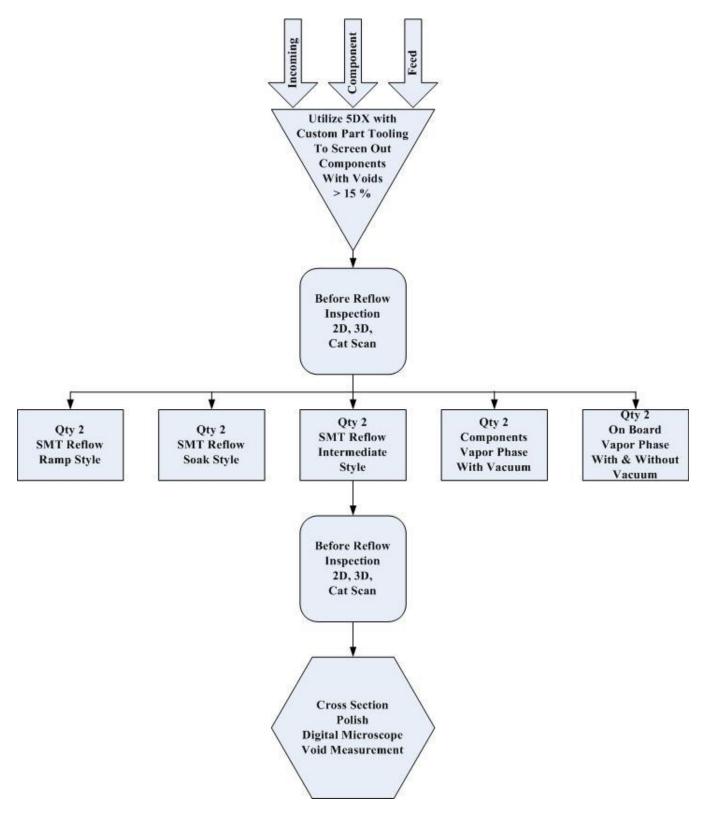


Figure 8 – Medium Soak SMT Reflow Profile

Follow process flow diagram show in Figure 9



**Figure 9 – Void Experiment Flow** 

#### **VOID DETECTION METHODOLOGY**

Three typical tools will be used for the experiment including 3D AXI (Figure 10), 2D X-Ray (Figure 11), Cross-Sectioning (Figure 12) along with a fourth non-typical tool called High Resolution CT Scan (Figure 13)

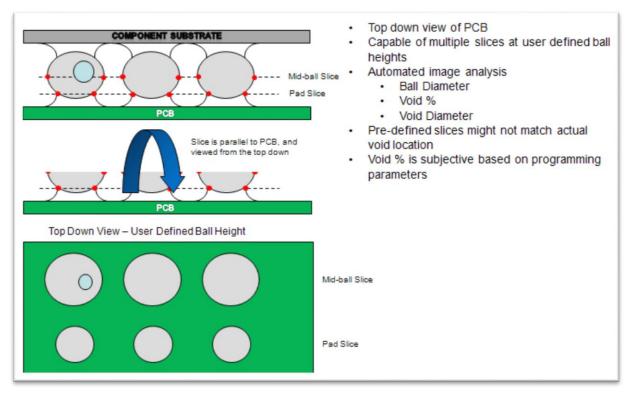


Figure 10 – 3D AXI Tool

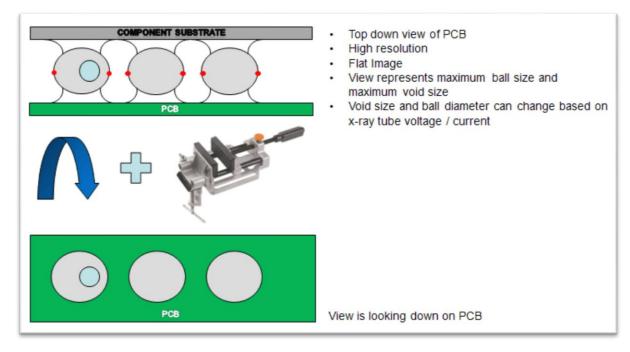
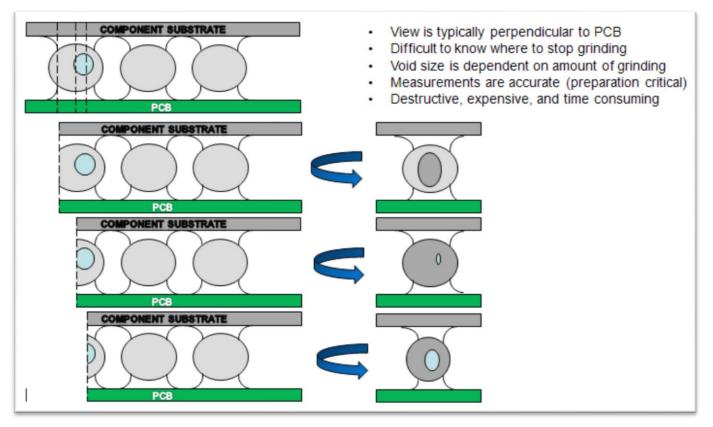


Figure 11 – 2D X-Ray Tool



**Figure 12 – Cross-Sectioning Tool** 



- Non-destructive
- Metrology Full dimensional analysis of solder / component characteristics
- Infinite cross sectioning capability
- Analysis is time consuming, with no automated analysis
- Geared toward Failure Analysis
- Costly for large form factors, up 36"x 48"scannable area

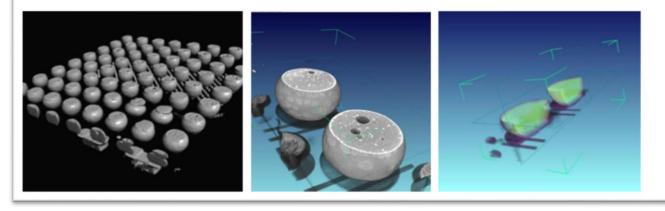


Figure 13 – High Resolution CT Scan Tool

#### Results

Figures 14 and Figure 15 show examples of the images collected from the experiment.

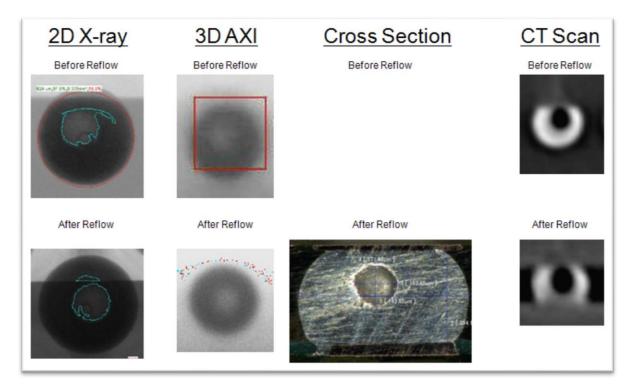


Figure 14 – Example 1 Of Images Collected using various tools

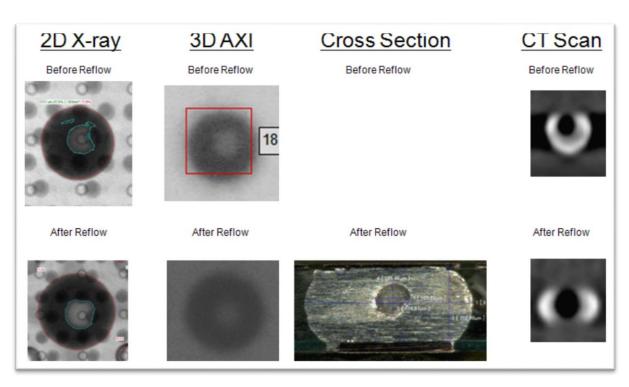


Figure 15 – Example 2 Of Images Collected using various tools

Tables 1 through 4 show the various measurements for comparison along with images to help explain the data.

|           |       | 3D A         | AXI        |            |            | Pre-Reflow   | Post-Reflow  |  |
|-----------|-------|--------------|------------|------------|------------|--|--|--|
|           |       |              |            | After      |            | and the second second  |  | _  |
|           |       |              | Before     | Reflow - % | % V oid    | The second s   |  |  |
|           |       |              | Reflow - % | Area       | Area       | CONTRACTOR OF THE OWNER.   | The second s   | 1000                                     |
| Component |       | Oven Profile |            | Voided     | In cre ase | A CONTRACTOR OF A  | CONTRACTOR OF  | 3D AXI                                   |
| Sample1   | 37    | Long Soak    | 19.92%     |            | 8.43%      | - Internet Address   |  | Top Down                                 |
| Sample1   | 1 22  |              | 18.57%     | 23.67%     | 27 .45 %   | a state of the second second   |  | Mid-ball Vie                             |
| Sample 2  | 6     | Long Soak    | 15.12%     | 0.00%      | -100.00%   | Contraction of the local division of the loc | Contraction of the local division of the loc |  |
| Sample 2  | 318   | Long Soak    | 1 3.15%    | 2 3.3 6%   | 77.64%     |  | 0.000 000000000000000000000000000000000  |  |
| Sample 2  | 7 33  | Long Soak    | 1 2.04%    | 14.44%     | 19.93%     |  |  | -  |
| Sample 2  | 2254  | Long Soak    | 10.73%     | 0.00%      | -100.00%   |  |  |  |
| Sample 3  | 2090  | MediumSoak   | 1 6.00%    | 4157%      | 159 21%    |  |  |  |
| Sample4   | 111   | MediumSoak   | 19.40%     | 28.32%     | 45.98%     |  | and the second se  |  |
| Sample5   | 363   | Ramp to Peak | 1 6.59%    | 19.38%     | 16.82%     |  |  | OTO                                      |
| Sample 6  | 5 21  | Pamp to Peak | 1 3.10%    | 35.00%     | 167 18%    | and the second se  |  | CT Scan                                  |
| Sample 6  | 11 65 | Pamp to Peak | 10.73%     | 25.79%     | 140.35%    |  |  | Perpendicu                               |
| Sample 6  | 1185  | Pamp to Peak | 10.73%     | 21.77%     | 102.89%    |  |  | view                                     |
| Sample 6  | 1385  | Pamp to Peak | 18.77%     | 4 3.8 2%   | 133,46%    |  |  |  |
| Sample 6  | 1388  | Pamp to Peak | 15.72%     | 22.80%     | 45.04%     |  | and the second second second second  |  |
| Sample 7  | 917   | Vapor Phase  | 1 2.75%    |            |            |  |  |  |
|           |       | Vapor w/     |            |            |            |  |  |  |
| Sample7   | 1174  | Vac uum      | 24.00%     |            |            |  |  |  |
|           |       | Vapor w/     |            |            |            |  |  |  |
| Sample7   | 1679  | Vac uum      | 1 2.00%    |            |            | <ul> <li>Max void size por</li> </ul>  | sition does not always   | s align with                             |
| Sample®   | 366   | Vapor Phase  | 22.43%     |            |            | pre-defined AXI s  |  | a na an |
| Sample®   | 2194  |              | 1 2.37%    |            |            | pre sermes/end   |  |  |
|           |       | Vapor w/     |            |            |            |  |  |  |
| Sample 9  | 275   |              | 11.89%     |            |            |  |  |  |
|           |       | Vapor w/     |            |            |            |  |  |  |
| Sample 9  | 379   | Vac uum      | 14.89%     |            |            |  |  |  |

Table 1 – 3D AXI Results

| 2D X-ray  |              |                     |                                     |                                    |                         |  |  |  |
|-----------|--------------|---------------------|-------------------------------------|------------------------------------|-------------------------|--|--|--|
| Component | Pin Location | Oven Profile        | Before Reflow<br>- % Area<br>Voided | After Reflow -<br>% Area<br>Voided | % Void Area<br>Increase |  |  |  |
| Sample 1  | 37           | Long Scale          | 15.90%                              | 16.40%                             | 314%                    |  |  |  |
| Sample 1  | 122          | Long Soak           | 15.20%                              | 15.20%                             | -3.20%                  |  |  |  |
| Sample 2  | 6            | Long Soak           | 1 2.00%                             | 0.00%                              | -100.00%                |  |  |  |
| Sample 2  | 318          | Long Soak           | 11.70%                              | 15.70%                             | 34 19 %                 |  |  |  |
| Sample 2  | 733          | Long Soak           | 1 3.7 0%                            | 16.00%                             | 16.79%                  |  |  |  |
| Sample 2  | 2254         | Long Scak           | 1120%                               | 0.00%                              | -100.00%                |  |  |  |
| Sample 3  | 209.0        | MediumSoak          | 17.00%                              | 23.40%                             | 37.65%                  |  |  |  |
| Sample 4  | 111          | MediumSoak          | 16.60%                              | 18.10%                             | 9.04%                   |  |  |  |
| Sample 5  | 363          | Pamp to Peak        | 11.60%                              | 11.30%                             | -2.59%                  |  |  |  |
| Sample 6  | 521          | Pamp to Peak        | 15.20%                              | 20.10%                             | 32.24%                  |  |  |  |
| Sample 6  | 1165         | Pamp to Peak        | 11.00%                              | 15.40%                             | 40.00%                  |  |  |  |
| Sample 6  | 1185         | Pamp to Peak        | 9.90%                               | 11.10%                             | 1212%                   |  |  |  |
| Sample 6  | 1305         | Ramp to Peak        | 25.30%                              | 28.50%                             | 12.65%                  |  |  |  |
| Sample 6  | 1388         | Pamp to Peak        | 1 3.60%                             | 17.10%                             | 25.74%                  |  |  |  |
| Sample 7  | 917          | Va por Phase        | 1620%                               | 0.00%                              | -100.00%                |  |  |  |
| Sample 7  | 1174         | Vapor w/<br>Vacuum  | 11.74%                              | 0.00%                              | -100.00%                |  |  |  |
| Sample 7  | 1679         | Vapor w/<br>Vac uum | 11.7 0%                             | 0.00%                              | -100.00%                |  |  |  |
| Sample 8  | 36.6         | Va por Phase        | 21.30%                              |                                    |                         |  |  |  |
|           |              |                     |                                     |                                    |                         |  |  |  |

9.7 0%

1140%

14.30%

0.009

0.00%

2194 Vapor Phase

275

379

Vapor w/

Vac uum

Vapor w/

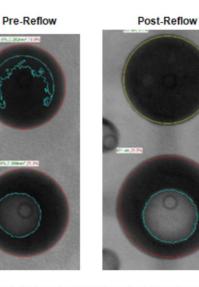
Vac uum

Sample S

Sample 9

Sample 9

Table 2 – 2D X-RayResults



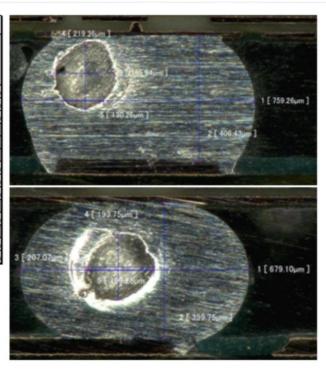
 Max ball diameter, void diameter with only x, y void position information

· Void diameter increase not proportional to void % area increase

#### Table 3 – Cross-Sectioning Results

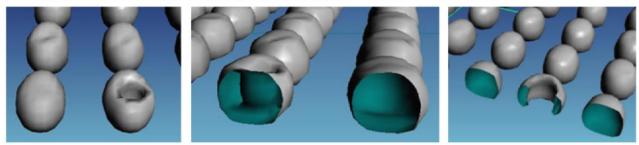
| Physcial Cross Section |              |              |             |          |             |  |  |  |  |  |
|------------------------|--------------|--------------|-------------|----------|-------------|--|--|--|--|--|
| Componen               | Pin Location | Oven Profile | Max V oid X | Void Y   | % Void Area |  |  |  |  |  |
| Sample 1               | 37           | Long Soak    | 183.69      | 17148    | 11.2%       |  |  |  |  |  |
| Sample 1               | 122          | Long Soak    | 1 69 .22    | 16146    | 10.0%       |  |  |  |  |  |
| Sample 2               | 6            | Long Soak    | 195.94      | 219.36   | 14.6%       |  |  |  |  |  |
| Sample 2               | 318          | Long Soak    |             |          |             |  |  |  |  |  |
| Sample 2               | 733          | Long Soak    |             |          |             |  |  |  |  |  |
| Sample 2               | 2254         | Long Soak    |             |          |             |  |  |  |  |  |
| Sample 3               | 2090         | Medium Soa k | 207.07      | 19 3.75  | 15.5%       |  |  |  |  |  |
| Sample 4               | 111          | Medium Soa k | 219.32      | 18 2.6 2 | 14.2%       |  |  |  |  |  |
| Sample 5               | 363          | Pamp to Peak | 213.75      | 20 3.7 7 | 15.0%       |  |  |  |  |  |
| Sample 6               | 521          | Pamp to Peak |             |          |             |  |  |  |  |  |
| Sample 6               | 1165         | Ramp to Peak | 283.92      | 30 2 2 7 | 29.6%       |  |  |  |  |  |
| Sample 6               | 1185         | Pamp to Peak |             |          |             |  |  |  |  |  |
| Sample 6               | 1 38 5       | Ramp to Peak | 262.73      | 22716    | 22.0%       |  |  |  |  |  |
| Sample 6               | 1388         | Pamp to Peak | 251.6       | 220,49   | 18.9%       |  |  |  |  |  |

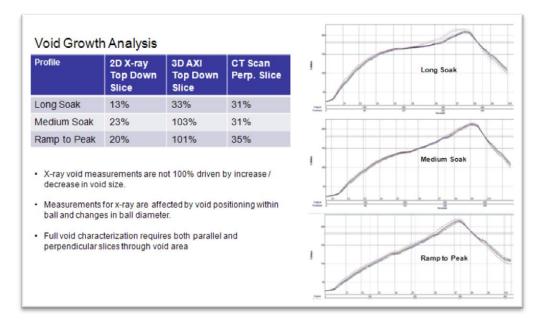
- Measurements are most accurate among utilized technologies
- Difficult to know which direction to grind into ball without other x-ray tools as a guide
- · Difficult to grind parallel to component package
- · Easy to stop short, or grind past maximum void position



|          |              |              |               | CT Scan       |              |                 |              |                    | <ul> <li>CT Imaging allows</li> </ul> |
|----------|--------------|--------------|---------------|---------------|--------------|-----------------|--------------|--------------------|---------------------------------------|
|          |              |              | Before - Void | Before - Void | After - Void | After - Void Y- | Percent X -  | Percent Y -<br>Dim | complete void and<br>characterization |
| omponent | Pin Location | Oven Profile | X-Dim (um)    | Y-Dim (um)    | X-Dim (um)   | Dim (um)        | Dim Increase | Increase           |                                       |
| Sample 1 | 37           | Long Soa k   | 2 28.7 3      | 264.25        | 2 65.39      | 317.90          | 16.0%        | 20.3%              |                                       |
| Sample 1 | 1 22         | Long Soa k   | 234.53        | 29 2 9 3      | 3 33.00      | 392.93          | 42.0%        | 341%               |                                       |
| Sample 2 | 6            | Long Soa k   | 171.42        | 18 2.9 6      | 176.91       | 204.34          | 3.2%         | 11.7%              |                                       |
| Sample 2 | 318          | Long Soa k   | 205.07        | 260.8 2       | 304.17       | 406.58          | 48.3%        | 55.9%              |                                       |
| Sample 2 | 7 33         | Long Soa k   | 221.06        | 255.09        | 311.70       | 391.72          | 41.0%        | 5 3.6%             |                                       |
| Sample 2 | 2254         | Long Soa k   | 205.43        | 27 3.8 3      | 245.52       | 3 38 .25        | 19.5%        | 23.5%              |                                       |
| Sample 3 | 2090         | MediumSoak   | 278.26        | 331.69        | 389.63       | 475.51          | 40.0%        | 43,4%              |                                       |
| Sample 4 | 111          | Medium Soak  | 233.43        | 30 6.7 6      | 288.22       | 363.27          | 23.5%        | 18.4%              |                                       |
| Sample 5 | 363          | Ramp to Peak | 241.36        | 18954         | 248.69       | 316.29          | 3.0%         | 66.9%              |                                       |
| Sample 6 | 5 21         | Pamp to Peak |               |               | 365.50       | 4 66 49         |              |                    |                                       |
| Sample 6 | 11 65        | Pamp to Peak |               |               | 395.58       | 270 A5          |              |                    |                                       |
| Sample 6 | 1185         | Pamp to Peak |               |               |              |                 |              |                    |                                       |
| Sample 6 | 1385         | Pamp to Peak |               |               | 414.28       | 478.52          |              |                    |                                       |
| Sample 6 | 1388         | Pamp to Peak |               |               |              |                 |              |                    |                                       |

#### Table 4 – High Resolution Cat Scan Results





#### Table 5 = Effect of Profiling On Void Growth

Part of the experiment involved reflowing components in a Vapor Phase Reflow machine and turning on vacuum. Figure 16 show some basic information about the oven used, chemistry and parameters.

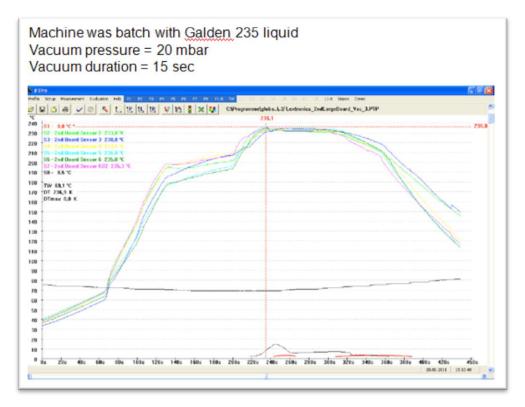


Figure 16 - Vapor Phase Reflow Details

Figure 17 shows the 2D X-Ray images before and after reflowing in the Vapor Phase oven using vacuum. 3D AXI was first used to confirm there were no detectable voids. 2D X-Ray images compare the same balls which confirm voids have mostly been removed beyond detection. CT Scans were not taken based on these results.

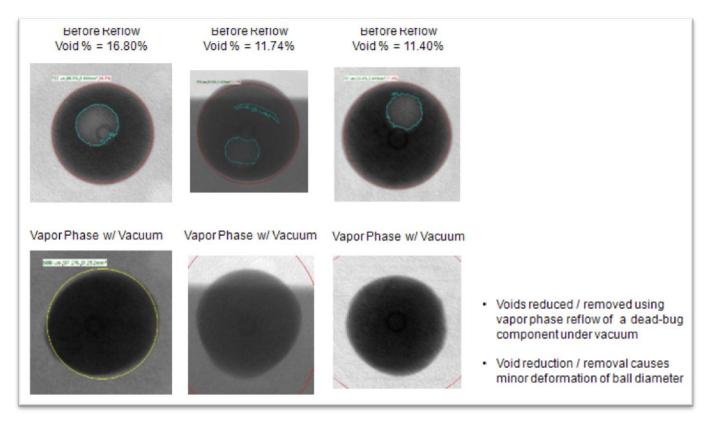
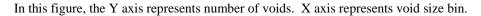


Figure 17 – Before and After results from Vapor Phase testing

#### DISCUSSION

From multiple void studies, it has been demonstrated that a soak style profile can greatly reduce voiding. Figure 18 shows an example of a void study using data from 3D X-Ray. This study was conducted on OSP PCB finish in Nitrogen environment. While one vendor may work slightly better at a ramp style profile, most tend to benefit from this style of profile (confused – benefit from soak?). While SMT solder pastes are mostly designed to work in air, most work well in N2 and will survive a longer profile which is what a soak style profile would represent. If running in air, perhaps a ramp or intermediate profile may work better so the vendor and part number of the SMT solder paste needs to be considered for the expected run environment.



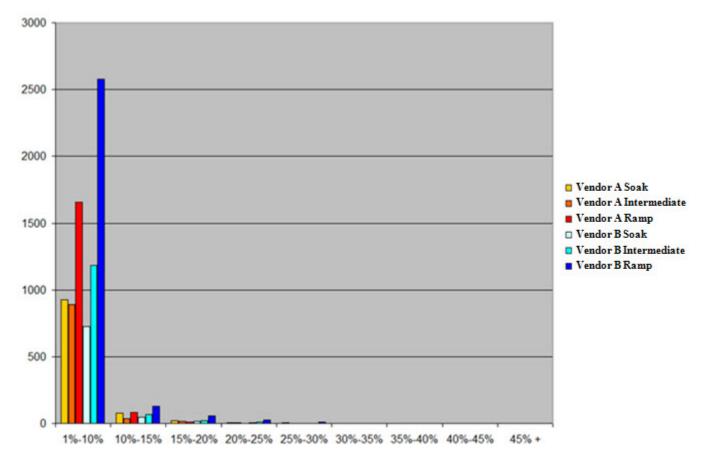


Figure 18 – Example of void study using size distribution

Based on the consistency of results from a variety of void studies in both SnPb and Pb Free, we concluded that a soak style profile eliminates or greatly reduces voiding when compared to an Intermediate style or Ramp style reflow profile. It is from this position that this experiment was conducted.

Knowing and understanding the characteristics of voiding relative to a particular brand and part number of solder paste will point users to whether the reflow process and/or chemistry (SMT solder paste) is causing the voiding issue. Inspection of incoming components will determine if voids are present on incoming parts. 2D or 3D x-ray can easily be used to inspect for voids on incoming components.

#### CONCLUSIONS

Table 6 was created to summarize the key characteristics of each tool. A number was assigned to rank the various tools in these characteristics based on experience. Depending on eash user and type of products / business, these may change slightly. Also, a weighting factor could be applied. The color (red, gree & yellow) is an added visual indicator.

|                      | 2D X-ray | 3D AXI | CTScan | <b>Cross-Section</b> |  |  |  |  |
|----------------------|----------|--------|--------|----------------------|--|--|--|--|
| Image Resolution     | 3        | 4      | 2      | 1                    |  |  |  |  |
| Preparation Time     | 1        | 2      | 3      | 4                    |  |  |  |  |
| Automation           | 2        | 1      | 3      | 4                    |  |  |  |  |
| Measurement Accuracy | 3        | 4      | 2      | 1                    |  |  |  |  |
| Slice Qty & Position | 4        | 2      | 1      | 3                    |  |  |  |  |
| Analysis Time        | 2        | 1      | 3      | 4                    |  |  |  |  |
| Void Location        | 4        | 3      | 1      | 2                    |  |  |  |  |
| 1 = Best 4 = Worst   |          |        |        |                      |  |  |  |  |

#### **Table 6 – Void Detection Tool Characteristic Rankings**

3D AXI is necessary to screen out significant quantities of components as data points, prior to further characterization

Combination of available void detection technologies are needed for complete characterization of process and components, especially for increased complexity (i.e. via in pad, finer pitch, etc,,,)

PCB and Component Design, Reflow profile parameters as well as chemistry can all affect growth and positioning of voids

High Resolution CT Imaging allows for a complete analysis of components before and after assembly in non-destructive manner

While IPC 7095B introduced tables for void process indicators and troubleshooting and JEDEC Std 217 has a guideline for component voids allowed (pre-reflow), a clear joint industry specification needs to be considered to create better linkage between component manufacturing and PCB Assembly & Inspection

#### ACKNOWLEDGEMENTS

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- Florian Wuest IBL Germany

Jochen Lipp – IBL USA



### Before and After Reflow Characterization of FCBA Voiding

Authors: Gordon O'Hara, Matthew Vandiver, Flextronics – Austin, TX

# APEX 2012 Mar 100 Control Cont

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- Background
- Experiment Parameters
- Tools for Void Identification
- Before & After Void Characterization
- Process Considerations for Void Minimization
- Void Removal
- Conclusions



## BACKGROUND

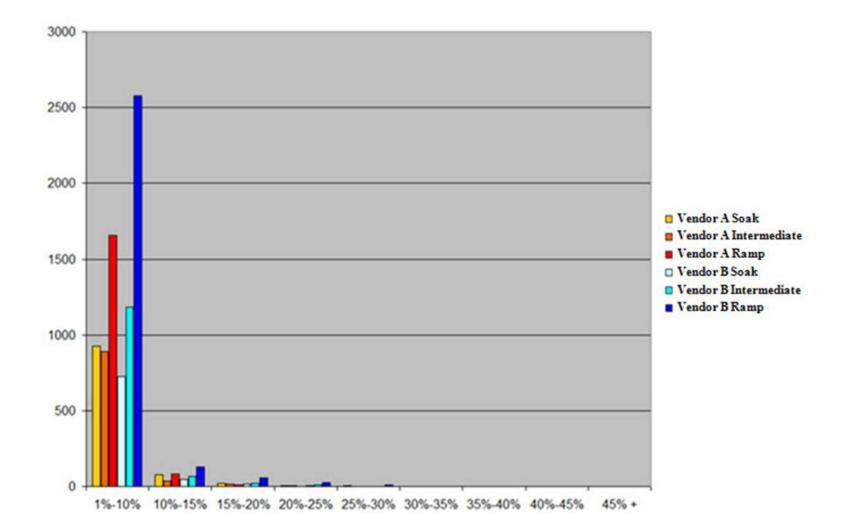
### TPS

# Background

- 3% component level fallout at 3D AXI due to voids failing to meet customer requirements
- Expensive component replacement cost
- Voiding isolated to specific component type from single source supplier
- Process and chemistry set characterized
- Test results indicted incoming component issue
- Developed tooling and AXI program for screening incoming material to <15% void area per JEDEC Standard 217 guidelines

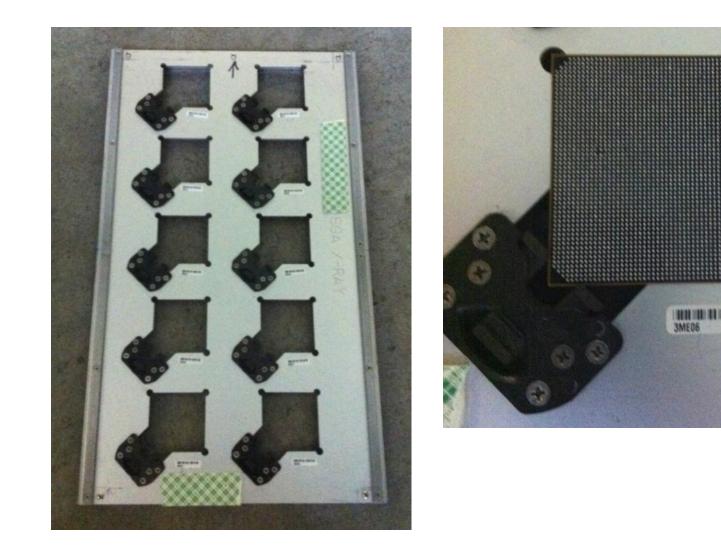


### **Process Characterization**





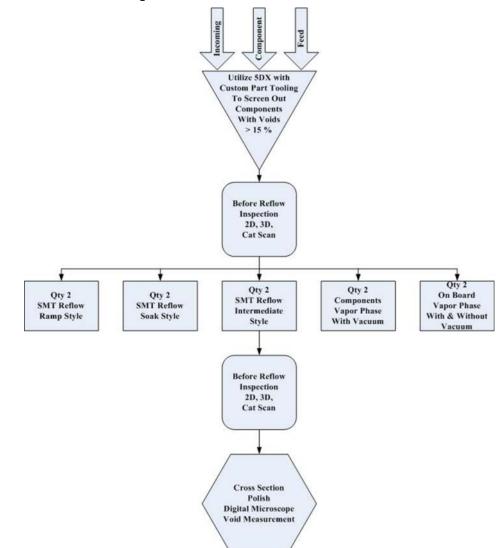
### Fixture for 3D AXI Screening





# **EXPERIMENT PARAMETERS**





- 10 FCBGA ASICS used for Analysis
- Before / After Reflow Void Characterization
  - 2D X-ray
  - 3D AXI
  - High Resolution CT Imaging
- After Reflow Cross-Sectioning



Void Detection Methodology

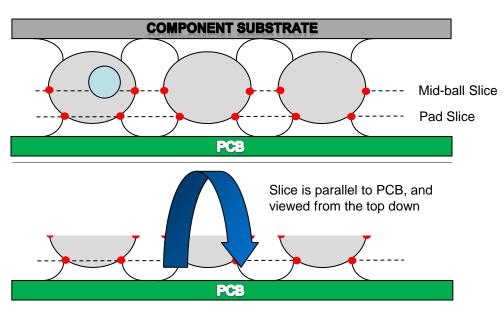
# **TOOLS FOR VOID IDENTIFICATION**

### 3D AXI

**EXPO**<sup>\*</sup> 2012

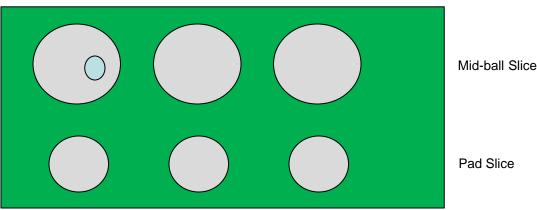
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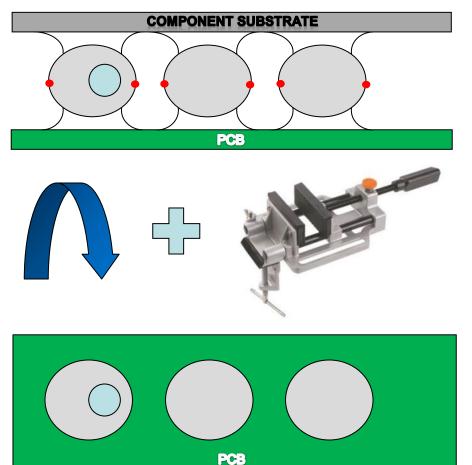
Top Down View – User Defined Ball Height



- Top down view of PCB
- Capable of multiple slices at user defined ball heights

- Automated image analysis
  - Ball Diameter
  - Void %
  - Void Diameter
- Pre-defined slices might not match actual void location
- Void % is subjective based on programming parameters

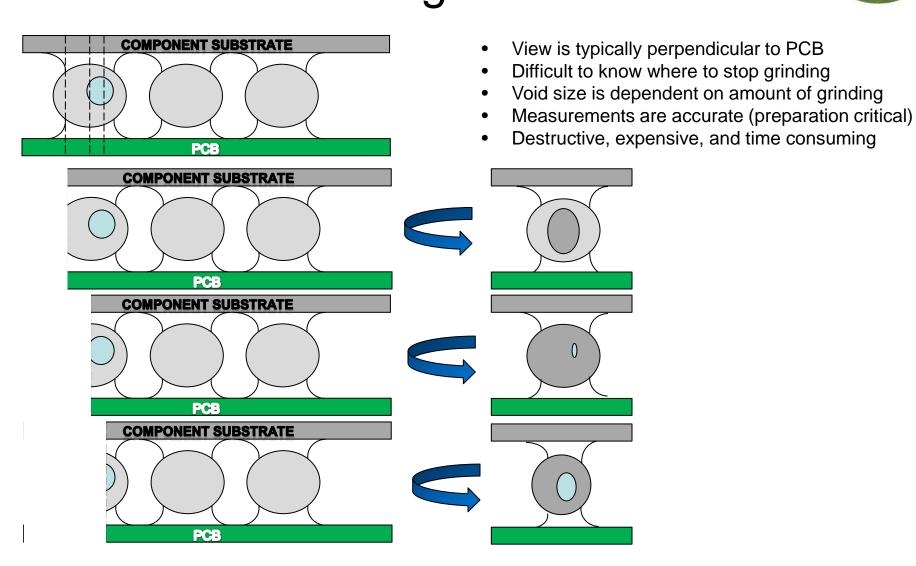




- Top down view of PCB
- High resolution
- Flat Image
- View represents maximum ball size and maximum void size
- Void size and ball diameter can change based on x-ray tube voltage / current

View is looking down on PCB



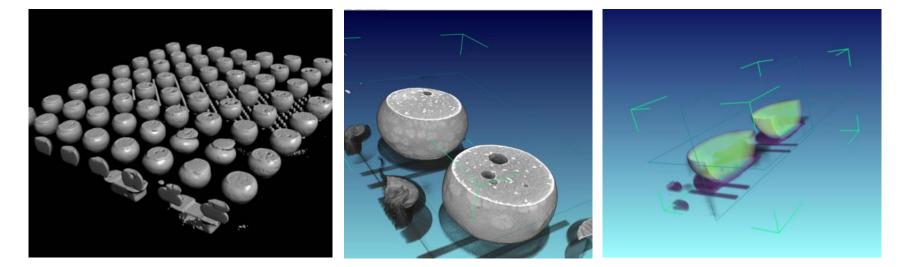






Horizontal Inspection

- Non-destructive
- Metrology Full dimensional analysis of solder / component characteristics
- Infinite cross sectioning capability
- Analysis is time consuming, with no automated analysis
- Geared toward Failure Analysis
- Costly for large form factors, up 36"x 48"scannable area



# **BEFORE & AFTER VOID CHARACTERIZATION**

Tps

CAN

7

**PO**<sup>\*</sup> 2012

**MANNAN** 



### Before / After – Example 1

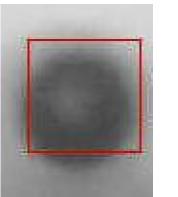
### <u>2D X-ray</u>

**Before Reflow** 

624 um,97.8%,0.305mm\*,15.9%

### <u>3D AXI</u>

#### Before Reflow



### Cross Section

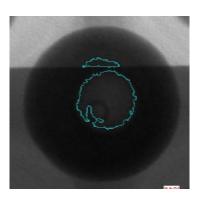
**Before Reflow** 

<u>CT Scan</u>

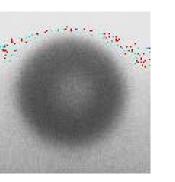
#### **Before Reflow**



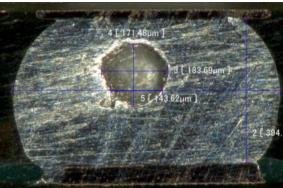
After Reflow



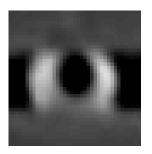
After Reflow



After Reflow



After Reflow





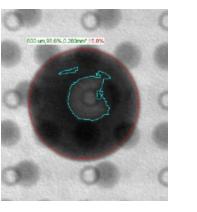
### Before / After – Example 2

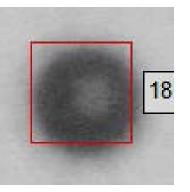
### <u>2D X-ray</u>

**Before Reflow** 

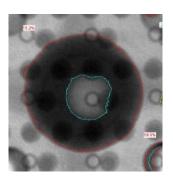
### <u>3D AXI</u>

#### Before Reflow





After Reflow



After Reflow

### 4 [181.46µm.] 3 [169.22µm.] 5 £ (56.97µm.) 2 £ 352.98µm.

After Reflow

**Cross Section** 

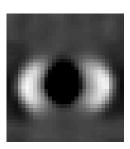
**Before Reflow** 

### CT Scan

Before Reflow



After Reflow





### Before / After Results – 3D AXI

TPS

| 3D AXI    |              |              |             |            |          |  |  |  |  |
|-----------|--------------|--------------|-------------|------------|----------|--|--|--|--|
|           |              |              |             | After      |          |  |  |  |  |
|           |              |              | Before      | Reflow - % | % Void   |  |  |  |  |
|           |              |              | Reflow - %  | Area       | Area     |  |  |  |  |
| Component | Pin Location | Oven Profile | Area Voided | Voided     | Increase |  |  |  |  |
| Sample 1  | 37           | Long Soak    | 19.92%      | 21.60%     | 8.43%    |  |  |  |  |
| Sample 1  | 122          | Long Soak    | 18.57%      | 23.67%     | 27.45%   |  |  |  |  |
| Sample 2  | 6            | Long Soak    | 15.12%      | 0.00%      | -100.00% |  |  |  |  |
| Sample 2  | 318          | Long Soak    | 13.15%      | 23.36%     | 77.64%   |  |  |  |  |
| Sample 2  | 733          | Long Soak    | 12.04%      | 14.44%     | 19.93%   |  |  |  |  |
| Sample 2  | 2254         | Long Soak    | 10.73%      | 0.00%      | -100.00% |  |  |  |  |
| Sample 3  | 2090         | Medium Soak  | 16.00%      | 41.57%     | 159.81%  |  |  |  |  |
| Sample 4  | 111          | Medium Soak  | 19.40%      | 28.32%     | 45.98%   |  |  |  |  |
| Sample 5  | 363          | Ramp to Peak | 16.59%      | 19.38%     | 16.82%   |  |  |  |  |
| Sample 6  | 521          | Ramp to Peak | 13.10%      | 35.00%     | 167.18%  |  |  |  |  |
| Sample 6  | 1165         | Ramp to Peak | 10.73%      | 25.79%     | 140.35%  |  |  |  |  |
| Sample 6  | 1185         | Ramp to Peak | 10.73%      | 21.77%     | 102.89%  |  |  |  |  |
| Sample 6  | 1385         | Ramp to Peak | 18.77%      | 43.82%     | 133.46%  |  |  |  |  |
| Sample 6  | 1388         | Ramp to Peak | 15.72%      | 22.80%     | 45.04%   |  |  |  |  |
| Sample 7  | 917          | Vapor Phase  | 12.75%      |            |          |  |  |  |  |
|           |              | Vapor w /    |             |            |          |  |  |  |  |
| Sample 7  | 1174         | Vacuum       | 24.00%      |            |          |  |  |  |  |
|           |              | Vapor w /    |             |            |          |  |  |  |  |
| Sample 7  | 1679         | Vacuum       | 12.00%      |            |          |  |  |  |  |
| Sample 8  | 366          | Vapor Phase  | 22.43%      |            |          |  |  |  |  |
| Sample 8  | 2194         | Vapor Phase  | 12.37%      |            |          |  |  |  |  |
|           |              | Vapor w /    |             |            |          |  |  |  |  |
| Sample 9  | 275          | Vacuum       | 11.89%      |            |          |  |  |  |  |
|           |              | Vapor w/     |             |            |          |  |  |  |  |
| Sample 9  | 379          | Vacuum       | 14.89%      |            |          |  |  |  |  |

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**Pre-Reflow** 



**Post-Reflow** 

3D AXI Top Down Mid-ball View





CT Scan Perpendicular view

 Max void size position does not always align with pre-defined AXI slices



### Before / After Results – 2D X-ray

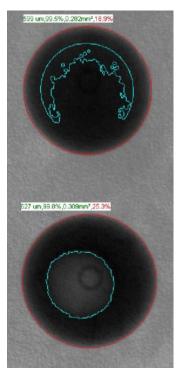
Tps

| 2D X-ray  |              |                     |                                     |                                    |                         |  |  |  |  |
|-----------|--------------|---------------------|-------------------------------------|------------------------------------|-------------------------|--|--|--|--|
| Component | Pin Location | Oven Profile        | Before Reflow<br>- % Area<br>Voided | After Reflow -<br>% Area<br>Voided | % Void Area<br>Increase |  |  |  |  |
| Sample 1  | 37           | Long Soak           | 15.90%                              | 16.40%                             | 3.14%                   |  |  |  |  |
| Sample 1  | 122          | Long Soak           | 15.80%                              | 15.20%                             | -3.80%                  |  |  |  |  |
| Sample 2  | 6            | Long Soak           | 12.00%                              | 0.00%                              | -100.00%                |  |  |  |  |
| Sample 2  | 318          | Long Soak           | 11.70%                              | 15.70%                             | 34.19%                  |  |  |  |  |
| Sample 2  | 733          | Long Soak           | 13.70%                              | 16.00%                             | 16.79%                  |  |  |  |  |
| Sample 2  | 2254         | Long Soak           | 11.80%                              | 0.00%                              | -100.00%                |  |  |  |  |
| Sample 3  | 2090         | Medium Soak         | 17.00%                              | 23.40%                             | 37.65%                  |  |  |  |  |
| Sample 4  | 111          | Medium Soak         | 16.60%                              | 18.10%                             | 9.04%                   |  |  |  |  |
| Sample 5  | 363          | Ramp to Peak        | 11.60%                              | 11.30%                             | -2.59%                  |  |  |  |  |
| Sample 6  | 521          | Ramp to Peak        | 15.20%                              | 20.10%                             | 32.24%                  |  |  |  |  |
| Sample 6  | 1165         | Ramp to Peak        | 11.00%                              | 15.40%                             | 40.00%                  |  |  |  |  |
| Sample 6  | 1185         | Ramp to Peak        | 9.90%                               | 11.10%                             | 12.12%                  |  |  |  |  |
| Sample 6  | 1385         | Ramp to Peak        | 25.30%                              | 28.50%                             | 12.65%                  |  |  |  |  |
| Sample 6  | 1388         | Ramp to Peak        | 13.60%                              | 17.10%                             | 25.74%                  |  |  |  |  |
| Sample 7  | 917          | Vapor Phase         | 16.80%                              | 0.00%                              | -100.00%                |  |  |  |  |
| Sample 7  | 1174         | Vapor w /<br>Vacuum | 11.74%                              | 0.00%                              | -100.00%                |  |  |  |  |
| Sample 7  | 1679         | Vapor w /<br>Vacuum | 11.70%                              | 0.00%                              | -100.00%                |  |  |  |  |
| Sample 8  | 366          | Vapor Phase         | 21.30%                              |                                    |                         |  |  |  |  |
| Sample 8  | 2194         | Vapor Phase         | 9.70%                               |                                    |                         |  |  |  |  |
| Sample 9  | 275          | Vapor w /<br>Vacuum | 11.40%                              | 0.00%                              |                         |  |  |  |  |
| Sample 9  | 379          | Vapor w /<br>Vacuum | 14.30%                              | 0.00%                              |                         |  |  |  |  |

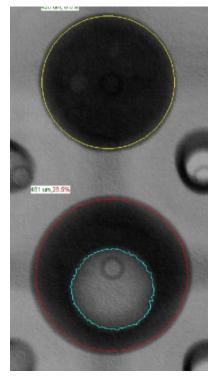
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#### **Pre-Reflow**



**Post-Reflow** 



- Max ball diameter, void diameter with only x,y void position information
- Void diameter increase not proportional to void % area increase

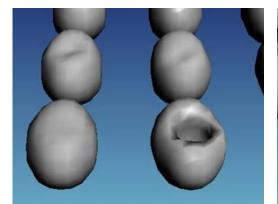


### Before / After Results – CT Scan

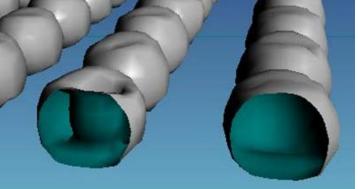
|           | CT Scan      |              |               |               |              |                 |              |             |  |  |  |  |
|-----------|--------------|--------------|---------------|---------------|--------------|-----------------|--------------|-------------|--|--|--|--|
|           |              |              |               |               |              |                 |              | Percent Y - |  |  |  |  |
|           |              |              | Before - Void | Before - Void | After - Void | After - Void Y- | Percent X -  | Dim         |  |  |  |  |
| Component | Pin Location | Oven Profile | X-Dim (um)    | Y-Dim (um)    | X-Dim (um)   | Dim (um)        | Dim Increase | Increase    |  |  |  |  |
| Sample 1  | 37           | Long Soak    | 228.73        | 264.25        | 265.39       | 317.90          | 16.0%        | 20.3%       |  |  |  |  |
| Sample 1  | 122          | Long Soak    | 234.53        | 292.93        | 333.08       | 392.93          | 42.0%        | 34.1%       |  |  |  |  |
| Sample 2  | 6            | Long Soak    | 171.42        | 182.96        | 176.91       | 204.34          | 3.2%         | 11.7%       |  |  |  |  |
| Sample 2  | 318          | Long Soak    | 205.07        | 260.82        | 304.17       | 406.58          | 48.3%        | 55.9%       |  |  |  |  |
| Sample 2  | 733          | Long Soak    | 221.06        | 255.09        | 311.70       | 391.72          | 41.0%        | 53.6%       |  |  |  |  |
| Sample 2  | 2254         | Long Soak    | 205.43        | 273.83        | 245.52       | 338.25          | 19.5%        | 23.5%       |  |  |  |  |
| Sample 3  | 2090         | Medium Soak  | 278.26        | 331.69        | 389.63       | 475.51          | 40.0%        | 43.4%       |  |  |  |  |
| Sample 4  | 111          | Medium Soak  | 233.43        | 306.76        | 288.22       | 363.27          | 23.5%        | 18.4%       |  |  |  |  |
| Sample 5  | 363          | Ramp to Peak | 241.36        | 189.54        | 248.69       | 316.29          | 3.0%         | 66.9%       |  |  |  |  |
| Sample 6  | 521          | Ramp to Peak |               |               | 365.50       | 466.49          |              |             |  |  |  |  |
| Sample 6  | 1165         | Ramp to Peak |               |               | 395.58       | 270.45          |              |             |  |  |  |  |
| Sample 6  | 1185         | Ramp to Peak |               |               |              |                 |              |             |  |  |  |  |
| Sample 6  | 1385         | Ramp to Peak |               |               | 414.28       | 478.52          |              |             |  |  |  |  |
| Sample 6  | 1388         | Ramp to Peak |               |               |              |                 |              |             |  |  |  |  |

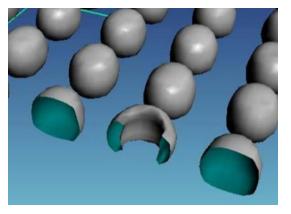
Tps

• CT Imaging allows for complete void and ball characterization



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### **Cross-Section Results**

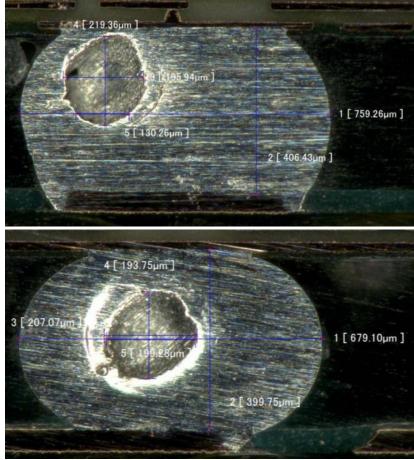
Tp>

|          | Physcial Cross Section |              |            |        |             |  |  |  |  |  |
|----------|------------------------|--------------|------------|--------|-------------|--|--|--|--|--|
| Componen | Pin Location           | Oven Profile | Max Void X | Void Y | % Void Area |  |  |  |  |  |
| Sample 1 | 37                     | Long Soak    | 183.69     | 171.48 | 11.2%       |  |  |  |  |  |
| Sample 1 | 122                    | Long Soak    | 169.22     | 161.46 | 10.0%       |  |  |  |  |  |
| Sample 2 | 6                      | Long Soak    | 195.94     | 219.36 | 14.6%       |  |  |  |  |  |
| Sample 2 | 318                    | Long Soak    |            |        |             |  |  |  |  |  |
| Sample 2 | 733                    | Long Soak    |            |        |             |  |  |  |  |  |
| Sample 2 | 2254                   | Long Soak    |            |        |             |  |  |  |  |  |
| Sample 3 | 2090                   | Medium Soak  | 207.07     | 193.75 | 15.5%       |  |  |  |  |  |
| Sample 4 | 111                    | Medium Soak  | 219.32     | 182.62 | 14.2%       |  |  |  |  |  |
| Sample 5 | 363                    | Ramp to Peak | 213.75     | 203.77 | 15.0%       |  |  |  |  |  |
| Sample 6 | 521                    | Ramp to Peak |            |        |             |  |  |  |  |  |
| Sample 6 | 1165                   | Ramp to Peak | 283.92     | 302.87 | 29.6%       |  |  |  |  |  |
| Sample 6 | 1185                   | Ramp to Peak |            |        |             |  |  |  |  |  |
| Sample 6 | 1385                   | Ramp to Peak | 262.73     | 227.16 | 22.0%       |  |  |  |  |  |
| Sample 6 | 1388                   | Ramp to Peak | 251.6      | 220.49 | 18.9%       |  |  |  |  |  |

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- Measurements are most accurate among utilized technologies
- Difficult to know which direction to grind into ball without other x-ray tools as a guide
- Difficult to grind parallel to component package
- Easy to stop short, or grind past maximum void position



## PROCESS CONSIDERATIONS FOR VOID MINIMIZATION



### **Oven Reflow Profiles**

Tps

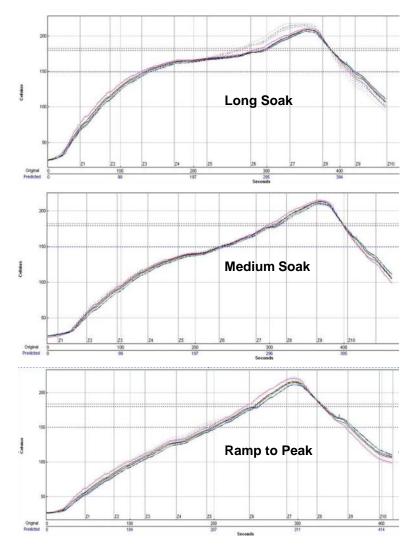
### Void Growth Analysis

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| Profile      | 2D X-ray<br>Top Down<br>Slice | 3D AXI<br>Top Down<br>Slice | CT Scan<br>Perp. Slice |
|--------------|-------------------------------|-----------------------------|------------------------|
| Long Soak    | 13%                           | 33%                         | 31%                    |
| Medium Soak  | 23%                           | 103%                        | 31%                    |
| Ramp to Peak | 20%                           | 101%                        | 35%                    |

- X-ray void measurements are not 100% driven by increase / decrease in void size.
- Measurements for x-ray are affected by void positioning within • ball and changes in ball diameter.
- Full void characterization requires both parallel and • perpendicular slices through void area





## **VOID REMOVAL**

### Vapor Phase Details

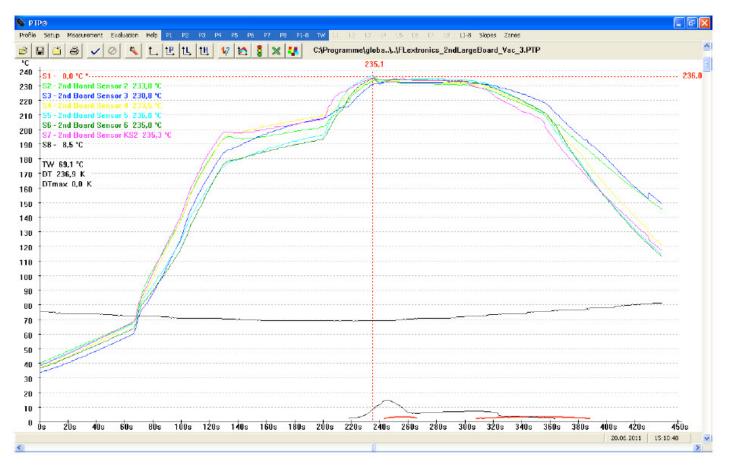
TP>

Machine was batch with Galden 235 liquid Vacuum pressure = 20 mbar Vacuum duration = 15 sec

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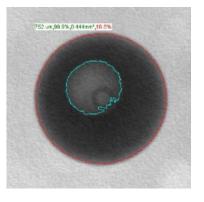
EXPO 2012 00

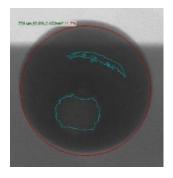




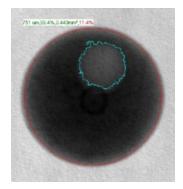
### Void Removal

Before Reflow Void % = 16.80% Before Reflow Void % = 11.74%

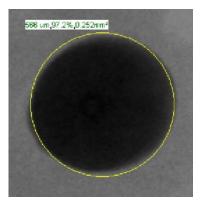




Before Reflow Void % = 11.40%

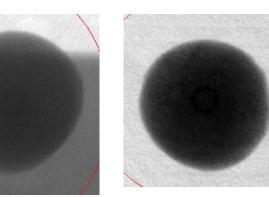


#### Vapor Phase w/ Vacuum



#### Vapor Phase w/ Vacuum

#### Vapor Phase w/ Vacuum



- Voids reduced / removed using vapor phase reflow of a dead-bug component under vacuum
- Void reduction / removal causes minor deformation of ball diameter



# CONCLUSIONS

# **Technology Comparison**

TPS

|                      | 2D X-ray | 3D AXI | CT Scan | <b>Cross-Section</b> |
|----------------------|----------|--------|---------|----------------------|
| Image Resolution     | 3        | 4      | 2       | 1                    |
| Preparation Time     | 1        | 2      | 3       | 4                    |
| Automation           | 2        | 1      | 3       | 4                    |
| Measurement Accuracy | 3        | 4      | 2       | 1                    |
| Slice Qty & Position | 4        | 2      | 1       | 3                    |
| Analysis Time        | 2        | 1      | 3       | 4                    |
| Void Location        | 4        | 3      | 1       | 2                    |

1 = Best 4 = Worst

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# Final Thoughts

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- 3D AXI is necessary to screen out significant quantities of components as data points, prior to further characterization
- Combination of available void detection technologies are needed for complete characterization of process and components, especially for increased complexity (i.e. via in pad, finer pitch, etc,,,)
- PCB and Component Design, Reflow profile parameters as well as chemistry can all affect growth and positioning of voids
- High Resolution CT Imaging allows for a complete analysis of components before and after assembly in non-destructive manner
- While IPC 7095B introduced tables for void process indicators and troubleshooting and JEDEC Std 217 has a guideline for component voids allowed (pre-reflow), a clear joint industry specification needs to be considered to create better linkage between component manufacturing and PCB Assembly & Inspection



### Acknowledgements

- Jonathan Crilly Flextronics
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- Taylor Blair Flextronics
- Nick Brinkhoff North Star Imaging
- Florian Wuest IBL
- Jochen Lipp IBL



### THANK YOU